

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

|                                       |   |                            |
|---------------------------------------|---|----------------------------|
| Applicant: Shunichiro Tanigawa et al. | : |                            |
|                                       | : | Art Unit: Not yet assigned |
| Serial No.:                           | : |                            |
|                                       | : | Examiner: Not yet assigned |
| Filed:                                | : |                            |
|                                       | : |                            |
| For:                                  | : |                            |
| CORRECTION COEFFICIENT                | : |                            |
| CALCULATING METHOD FOR                | : |                            |
| X-RAY CT SYSTEMS, BEAM                | : |                            |
| HARDENING POST-                       | : |                            |
| PROCESSING METHOD                     | : |                            |
| THEREFOR, AND X-RAY CT                | : |                            |
| SYSTEM                                | : |                            |

**PRELIMINARY AMENDMENT**

Hon. Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Prior to the examination of this Application, please amend the Application as follows: